



D2: DOSIMETRIC E-FIELD PROBE



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Accreditation No.: **SCS 108**

Client

Certificate No: **EX3-3578 May08**

CALIBRATION CERTIFICATE

Object: **ES3DV4 - SN 3578**

Calibration procedure(s): **QA CAL-01 v3, QA CAL-14 v3 and QA CAL-23 v3
Calibration procedure for dosimetric E-field probes**

Calibration date: **May 20, 2008**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|----------------------------|-----------------|-------------------------------|-----------------------|
| Power meter E4419B | GB41293874 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41495277 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41498087 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 8-Aug-07 (No. 217-00719) | Aug-08 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-08 (No. 217-00787) | Apr-09 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 8-Aug-07 (No. 217-00720) | Aug-08 |
| Reference Probe ES3DV2 | SN: 3013 | 2-Jan-08 (No. ES3-3013_Jan08) | Jan-09 |
| DAE4 | SN: 660 | 3-Sep-07 (No. DAE4-660_Sep07) | Sep-08 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-07) | In house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-07) | In house check: Oct-08 |

| | Name | Function | Signature |
|----------------|----------------------|--------------------------|-----------|
| Calibrated by: | Kajko Polovic | Technical Manager | |
| Approved by: | Fin Donahoe | R&D Director | |

Issued: May 21, 2008

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Glossary:

| | |
|--------------------------|--|
| TSL | tissue simulating liquid |
| NORM _{x,y,z} | sensitivity in free space |
| ConvF | sensitivity in TSL / NORM _{x,y,z} |
| DCP | diode compression point |
| Polarization φ | φ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Probe EX3DV4

SN:3578

| | |
|------------------|------------------|
| Manufactured: | November 4, 2005 |
| Last calibrated: | April 24, 2007 |
| Recalibrated: | May 20, 2008 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: EX3DV4 SN:3578

Sensitivity in Free Space^A

Diode Compression^B

| | | | | |
|-------|----------------------|-------------------------------------|-------|--------------|
| NormX | 0.520 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP X | 98 mV |
| NormY | 0.500 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP Y | 90 mV |
| NormZ | 0.540 ± 10.1% | $\mu\text{V}/(\text{V}/\text{m})^2$ | DCP Z | 93 mV |

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL **900 MHz** **Typical SAR gradient: 5 % per mm**

| | | | |
|---|------------------------------|---------------|---------------|
| Sensor Center to Phantom Surface Distance | | 2.0 mm | 3.0 mm |
| SAR _{be} [%] | Without Correction Algorithm | 11.3 | 5.6 |
| SAR _{be} [%] | With Correction Algorithm | 0.6 | 0.2 |

TSL **1810 MHz** **Typical SAR gradient: 10 % per mm**

| | | | |
|---|------------------------------|---------------|---------------|
| Sensor Center to Phantom Surface Distance | | 2.0 mm | 3.0 mm |
| SAR _{be} [%] | Without Correction Algorithm | 9.2 | 4.6 |
| SAR _{be} [%] | With Correction Algorithm | 0.5 | 0.2 |

Sensor Offset

Probe Tip to Sensor Center **1.0 mm**

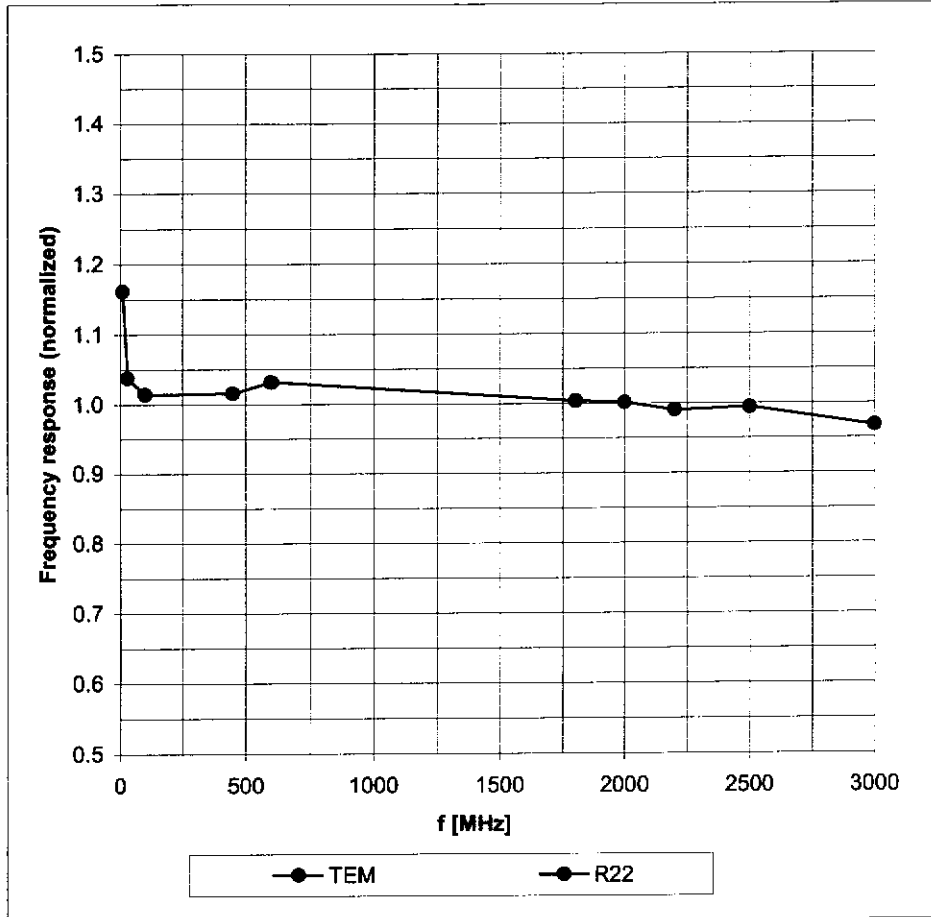
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

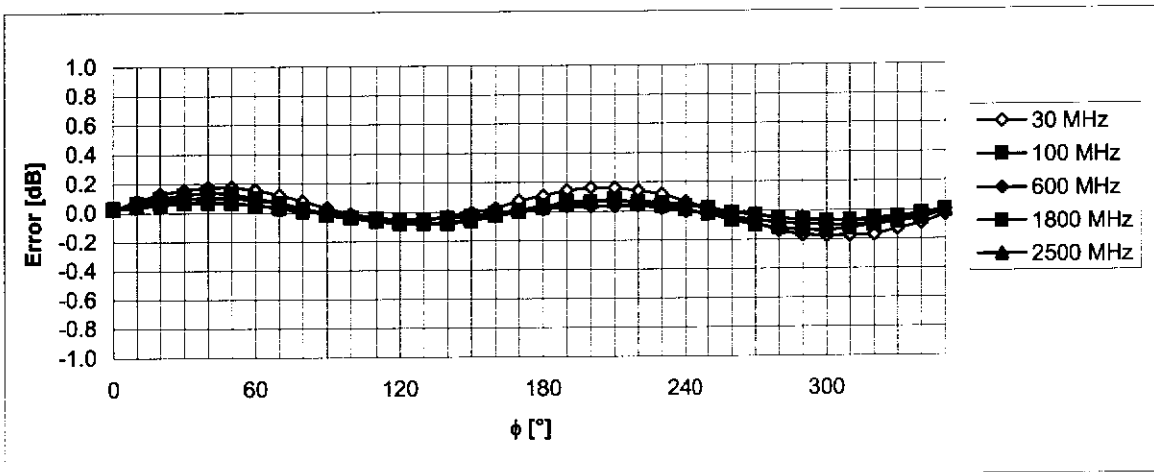
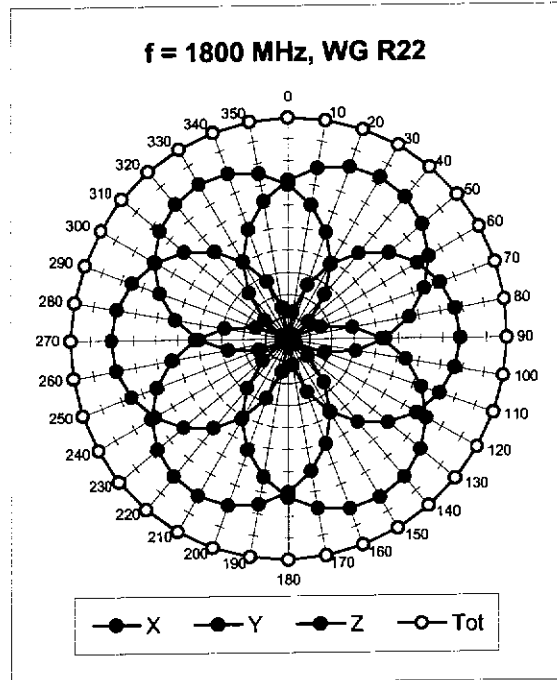
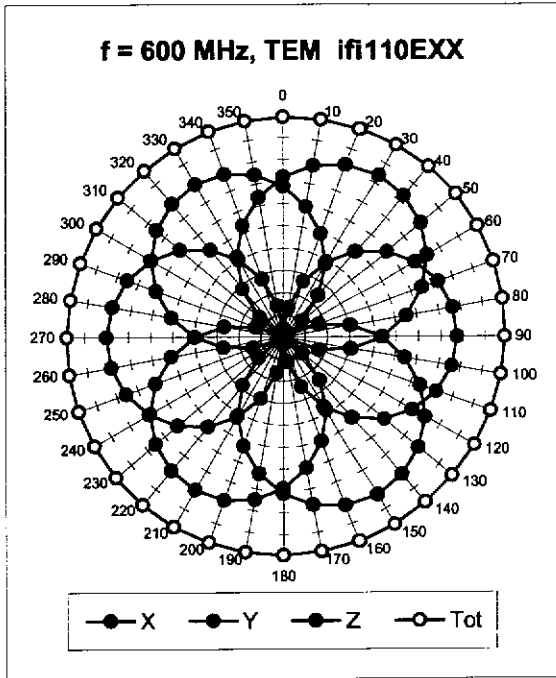
Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



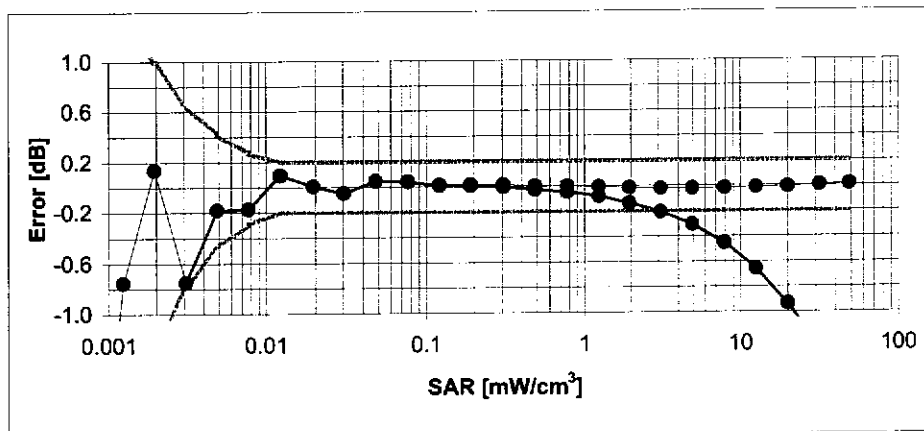
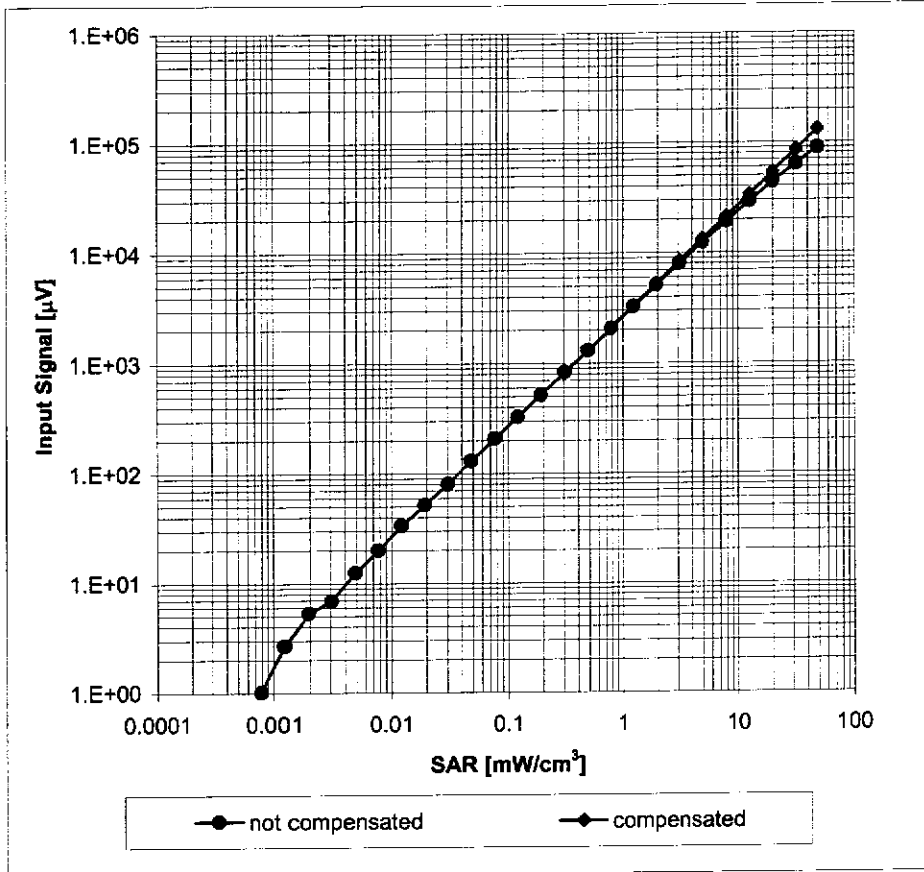
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



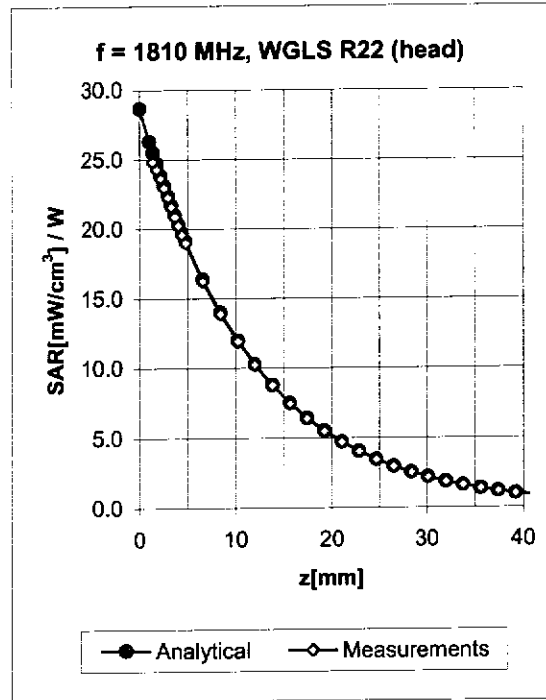
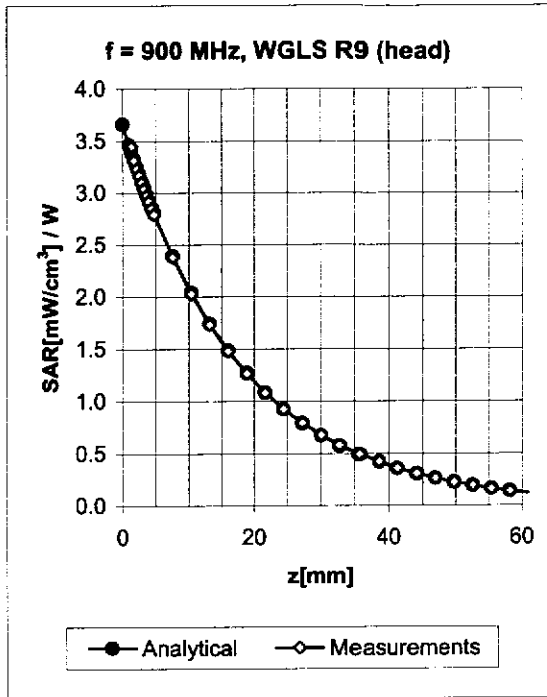
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Dynamic Range f(SAR_{head}) (Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

Conversion Factor Assessment

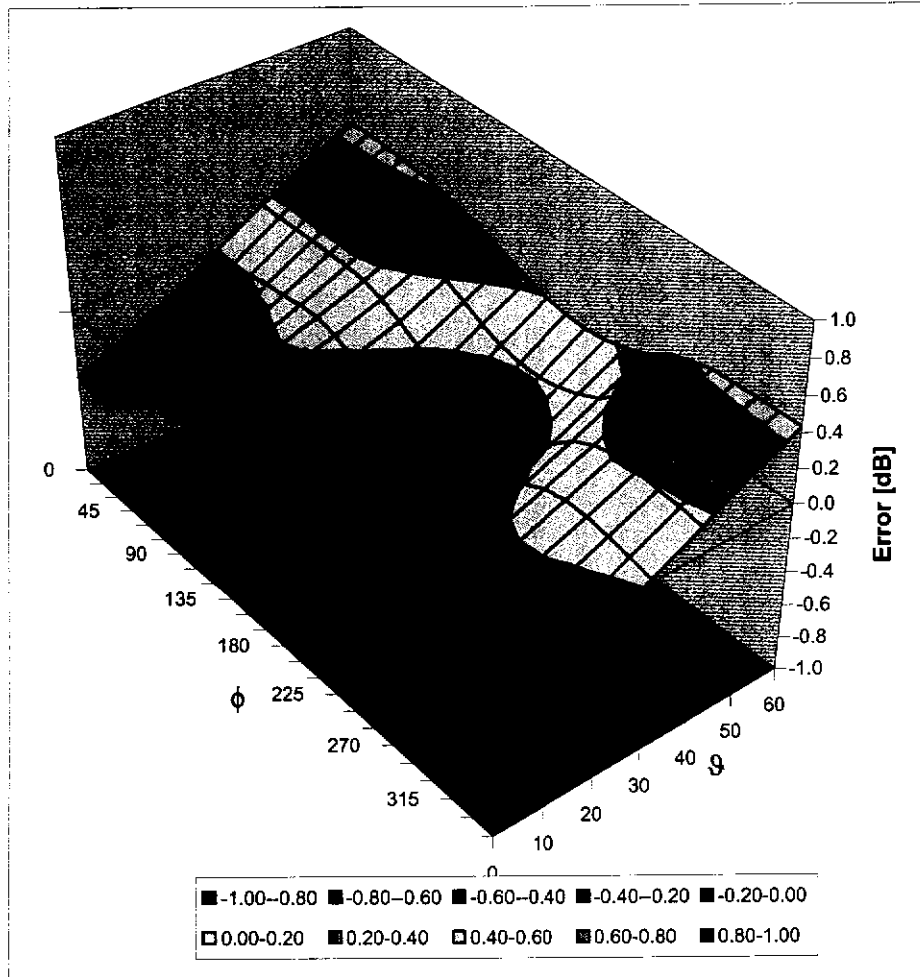


| f [MHz] | Validity [MHz] ^c | TSL | Permittivity | Conductivity | Alpha | Depth | ConvF Uncertainty |
|---------|-----------------------------|------|--------------|--------------|-------|-------|--------------------|
| 900 | ± 50 / ± 100 | Head | 41.5 ± 5% | 0.97 ± 5% | 0.48 | 0.80 | 8.55 ± 11.0% (k=2) |
| 1810 | ± 50 / ± 100 | Head | 40.0 ± 5% | 1.40 ± 5% | 0.51 | 0.75 | 7.28 ± 11.0% (k=2) |
| 2000 | ± 50 / ± 100 | Head | 40.0 ± 5% | 1.40 ± 5% | 0.48 | 0.77 | 7.10 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Head | 39.2 ± 5% | 1.80 ± 5% | 0.40 | 0.87 | 6.66 ± 11.0% (k=2) |
| 5200 | ± 50 / ± 100 | Head | 36.0 ± 5% | 4.66 ± 5% | 0.43 | 1.70 | 4.65 ± 13.1% (k=2) |
| 5500 | ± 50 / ± 100 | Head | 35.6 ± 5% | 4.96 ± 5% | 0.48 | 1.70 | 4.30 ± 13.1% (k=2) |
| 5800 | ± 50 / ± 100 | Head | 35.3 ± 5% | 5.27 ± 5% | 0.50 | 1.70 | 4.22 ± 13.1% (k=2) |
| 900 | ± 50 / ± 100 | Body | 55.0 ± 5% | 1.05 ± 5% | 0.45 | 0.80 | 8.42 ± 11.0% (k=2) |
| 1810 | ± 50 / ± 100 | Body | 53.3 ± 5% | 1.52 ± 5% | 0.49 | 0.80 | 7.41 ± 11.0% (k=2) |
| 2000 | ± 50 / ± 100 | Body | 53.3 ± 5% | 1.52 ± 5% | 0.43 | 0.87 | 7.08 ± 11.0% (k=2) |
| 2450 | ± 50 / ± 100 | Body | 52.7 ± 5% | 1.95 ± 5% | 0.55 | 0.80 | 6.55 ± 11.0% (k=2) |
| 5200 | ± 50 / ± 100 | Body | 49.0 ± 5% | 5.30 ± 5% | 0.47 | 1.75 | 3.84 ± 13.1% (k=2) |
| 5500 | ± 50 / ± 100 | Body | 48.6 ± 5% | 5.65 ± 5% | 0.35 | 1.75 | 4.12 ± 13.1% (k=2) |
| 5800 | ± 50 / ± 100 | Body | 48.2 ± 5% | 6.00 ± 5% | 0.46 | 1.75 | 3.92 ± 13.1% (k=2) |

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (ϕ, θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)



A D T

D3: DAE

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out .

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.



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Accreditation No.: **SCS 108**

Client **Jabil Circuits (Auden)**

Certificate No: **DAE4-861_Sep08**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BG - SN: 861**

Calibration procedure(s) **QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **September 22, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|-----------------------------------|--------------------|----------------------------|------------------------|
| Fluke Process Calibrator Type 702 | SN: 6295803 | 04-Oct-07 (No: 6467) | Oct-08 |
| Keithley Multimeter Type 2001 | SN: 0810278 | 03-Oct-07 (No: 6465) | Oct-08 |
| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
| Calibrator Box V1.1 | SE UMS 006 AB 1004 | 06-Jun-08 (in house check) | In house check: Jun-09 |

| | | | |
|----------------|------------------------------|-------------------------------------|---------------|
| Calibrated by: | Name Andrea Guntli | Function Technician | Signature |
| Approved by: | Name Fin Bomholt | Function R&D Director | Signature |

Issued: September 25, 2008

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement*: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity*: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity*: Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation*: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted*: Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current*: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance*: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage*: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption*: Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| Calibration Factors | X | Y | Z |
|---------------------|--------------------------|--------------------------|--------------------------|
| High Range | 404.365 \pm 0.1% (k=2) | 404.742 \pm 0.1% (k=2) | 405.670 \pm 0.1% (k=2) |
| Low Range | 4.02029 \pm 0.7% (k=2) | 3.98762 \pm 0.7% (k=2) | 4.01204 \pm 0.7% (k=2) |

Connector Angle

| | |
|---|-----------------------------------|
| Connector Angle to be used in DASY system | 124 $^{\circ}$ \pm 1 $^{\circ}$ |
|---|-----------------------------------|

Appendix

1. DC Voltage Linearity

| High Range | Input (μV) | Reading (μV) | Error (%) |
|-------------------|-------------------------|---------------------------|-----------|
| Channel X + Input | 200000 | 199999.9 | 0.00 |
| Channel X + Input | 20000 | 20002.71 | 0.01 |
| Channel X - Input | 20000 | -20003.54 | 0.02 |
| Channel Y + Input | 200000 | 200000.3 | 0.00 |
| Channel Y + Input | 20000 | 19999.17 | 0.00 |
| Channel Y - Input | 20000 | -20003.37 | 0.02 |
| Channel Z + Input | 200000 | 199999.8 | 0.00 |
| Channel Z + Input | 20000 | 20000.36 | 0.00 |
| Channel Z - Input | 20000 | -20005.96 | 0.03 |

| Low Range | Input (μV) | Reading (μV) | Error (%) |
|-------------------|-------------------------|---------------------------|-----------|
| Channel X + Input | 2000 | 2000 | 0.00 |
| Channel X + Input | 200 | 199.92 | -0.04 |
| Channel X - Input | 200 | -200.25 | 0.13 |
| Channel Y + Input | 2000 | 1999.9 | 0.00 |
| Channel Y + Input | 200 | 199.32 | -0.34 |
| Channel Y - Input | 200 | -200.67 | 0.33 |
| Channel Z + Input | 2000 | 2000 | 0.00 |
| Channel Z + Input | 200 | 199.65 | -0.18 |
| Channel Z - Input | 200 | -201.81 | 0.91 |

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Common mode Input Voltage (mV) | High Range Average Reading (μV) | Low Range Average Reading (μV) |
|-----------|--------------------------------|--|---|
| Channel X | 200 | 5.10 | 4.08 |
| | - 200 | -4.32 | -4.27 |
| Channel Y | 200 | 1.83 | 1.39 |
| | - 200 | -2.21 | -3.06 |
| Channel Z | 200 | -10.14 | -10.20 |
| | - 200 | 8.87 | 7.81 |

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | Input Voltage (mV) | Channel X (μV) | Channel Y (μV) | Channel Z (μV) |
|-----------|--------------------|-----------------------------|-----------------------------|-----------------------------|
| Channel X | 200 | - | 3.33 | 0.83 |
| Channel Y | 200 | 0.10 | - | 4.12 |
| Channel Z | 200 | -0.22 | 0.96 | - |

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 15980 | 15973 |
| Channel Y | 16090 | 15869 |
| Channel Z | 16031 | 16364 |

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

| | Average (μ V) | min. Offset (μ V) | max. Offset (μ V) | Std. Deviation (μ V) |
|-----------|--------------------|------------------------|------------------------|---------------------------|
| Channel X | -0.05 | -2.16 | 1.46 | 0.57 |
| Channel Y | -0.73 | -2.87 | 1.71 | 0.55 |
| Channel Z | -1.37 | -4.32 | 0.61 | 0.75 |

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

| | Zeroing (MOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 0.1999 | 197.8 |
| Channel Y | 0.2000 | 200.0 |
| Channel Z | 0.1999 | 198.0 |

8. Low Battery Alarm Voltage (verified during pre test)

| Typical values | Alarm Level (VDC) |
|----------------|-------------------|
| Supply (+ Vcc) | +7.9 |
| Supply (- Vcc) | -7.6 |

9. Power Consumption (verified during pre test)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.0 | +6 | +14 |
| Supply (- Vcc) | -0.01 | -8 | -9 |